

**Notice of References Cited**

Application/Control No.

09/514,489

Applicant(s)/Patent Under  
Reexamination  
BANIK ET AL.

Examiner

Tu X Nguyen

Art Unit

2684

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,122,271	09-2000	McDonald et al.	370/345
*	B	US-6,041,227	03-2000	Sumner, Terence Edward	379/88.1
	C	US-6,408,177	06-2002	Parikh et al.	455/414.4
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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